

Notice of References Cited	Application/Control No. 10/577,457	Applicant(s)/Patent Under Reexamination YAMANAKA, TAKAMITSU	
	Examiner SWAPNEEL CHHAYA	Art Unit 2895	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,136,643	10-2000	Jeng et al.	438/253
	B	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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